

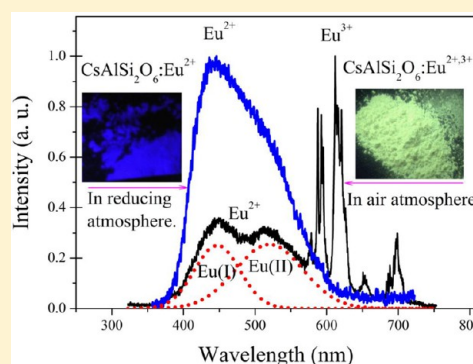
Abnormal Reduction, $\text{Eu}^{3+} \rightarrow \text{Eu}^{2+}$, and Defect Centers in Eu^{3+} -Doped Pollucite, $\text{CsAlSi}_2\text{O}_6$, Prepared in an Oxidizing Atmosphere

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ABSTRACT: Eu-doped pollucite $\text{CsAlSi}_2\text{O}_6$ was synthesized by the sol–gel method and heated in an air atmosphere. The crystal structure and the microstructure of the phosphors were investigated by X-ray powder diffraction and SEM images, respectively. The photoluminescence spectra and temperature dependent decay curves were measured. An abnormal reduction phenomenon of $\text{Eu}^{3+} \rightarrow \text{Eu}^{2+}$ was reported when Eu^{3+} ions were doped in alkaline metal cation sites in $\text{CsAlSi}_2\text{O}_6$ prepared in an oxidizing atmosphere. The abnormal mechanism was discussed on the basis of the charge compensation model and a rigid three-dimensional framework structure of $\text{CsAlSi}_2\text{O}_6$. The luminescence color centers were investigated by luminescence decay lifetimes and thermal stabilities of Eu^{2+} ions. The defect complexes of $[(\text{Eu}^{3+}_{\text{Cs}})^{\bullet\bullet} - 2V_{\text{Cs}}']$ or $[(\text{Eu}^{3+}_{\text{Cs}})^{\bullet\bullet} - \text{O}_i'']$ induced by the substitution of Eu^{3+} on Cs^+ were suggested in the lattices. Eu^{2+} ions could be regarded as Eu^{3+} ions combining with the released electrons from defects O_i'' or V_{Cs}' in close vicinity of Eu^{3+} ($\text{Eu}^{3+} + e$); the electrons cannot enter the atom track of Eu^{2+} presenting luminescence of Eu^{2+} ions. The results indicate that several defect traps can be attributed to the abnormal reduction mechanism of Eu^{3+} to Eu^{2+} ions in a matrix.



1. INTRODUCTION

Luminescence properties of divalent europium ion (Eu^{2+})-activated materials have been investigated in many kinds of hosts for lighting and display due to their intense excitation, strong broad emission band, and tunable luminescence colors. It is well-known that there is no natural material containing Eu^{2+} ions, so it is necessary to reduce Eu^{3+} to Eu^{2+} in a host. Usually this can be realized in a matrix if preparations are carried out in reducing atmospheres, such as H_2 , H_2/N_2 , or CO .

However, it is interesting that in some special compounds a reduction of trivalent rare earth ions (RE^{3+} ; $\text{RE} = \text{Sm}^{3+}$, Eu^{3+} , or Yb^{3+}) into divalent ions RE^{2+} (Sm^{2+} , Eu^{2+} , or Yb^{2+}) could happen even when samples were prepared in air at high temperature. Up to now, this “abnormal” reduction phenomenon, $\text{RE}^{3+} \rightarrow \text{RE}^{2+}$ in an oxidizing atmosphere, has been observed in the following hosts: borates (SrB_4O_7 ,¹ $\text{SrB}_6\text{O}_{10}$,² $\text{BaB}_8\text{O}_{13}$,¹ or CaB_2O_4),³ haloborate ($\text{Sr}_2\text{B}_3\text{O}_9\text{Cl}$),^{4,5} aluminates ($\text{Sr}_4\text{Al}_{14}\text{O}_{25}$,^{6,7} or BaAl_2O_4),⁸ phosphates ($\text{Ba}_3(\text{PO}_4)_2$ or NaCaPO_4),¹⁰ borophosphates (MBPO_5 , $\text{M} = \text{Ca}$, Sr , or Ba),^{11,12} silicate (BaMgSiO_4),¹³ sulfate (BaSO_4),¹⁴ borophosphate glasses ($\text{ZnO}-\text{B}_2\text{O}_3-\text{P}_2\text{O}_5$),¹⁵ and Eu/Al-codoped high silica glasses ($95.5\text{SiO}_2-4\text{B}_2\text{O}_3-0.5\text{Na}_2\text{O}$ (wt %)).¹⁶ This “abnormal” reduction was found to happen only in a special compound with rigid three-dimensional (3-D) enclosed crystal structures, with tetrahedral groups such as tetrahedral BO_4 , SiO_4 , AlO_4 , or PO_4 groups.¹

As a well-known aluminosilicate framework compound, pollucite ($\text{CsAlSi}_2\text{O}_6$), is of considerable interest because it

has relatively high resistance to alteration under hydrothermal conditions and, thus, can potentially be used as a solid host for radioactive cesium immobilization.^{17–19} Pollucite has unique thermal expansion; hence, it is used as a component in high-temperature glass-ceramic materials.^{20–22} In addition, natural pollucite, which commonly contains an analcime ($\text{CsAlSi}_2\text{O}_6 \cdot \text{H}_2\text{O}$) component and mainly occurs in rare-element granitic pegmatites, is the primary industrial source of cesium and is of petrogenetic interest as an indicator of the advanced stage in pegmatitic magma fractionation.^{23,24} Synthesis,²⁵ structure, and thermochemical study,²⁶ storage of radionuclides,²⁷ and substitution of impurity ions²⁴ in $\text{CsAlSi}_2\text{O}_6$ have been reported in recent years. Very recently, Zhang et al.²⁸ reported luminescence properties of Eu^{2+} -doped $\text{CsAlSi}_2\text{O}_6$ phosphors: blue-green color with CIE coordinates of ($x = 0.21$, $y = 0.32$) and a quantum efficiency of 67%. The possible application as a white light emission diode (LED) phosphor was suggested on the base of its bright blue-green luminescence and thermal stability.

Pollucite ($\text{CsAlSi}_2\text{O}_6$) can provide a rigid framework with covalent surrounding for RE^{2+} ion doping. In this work, we reported an abnormal reduction of $\text{Eu}^{3+} \rightarrow \text{Eu}^{2+}$ in pollucite, $\text{CsAlSi}_2\text{O}_6$, when the compound was prepared in air at high temperature. Photoluminescence excitation and emission together with decay curves were measured at different

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temperatures. The mechanism of this reduction was explained according to the charge compensation model and the rigid crystal structure. The color centers were first discussed on the basis of the luminescence properties and thermal stabilities of Eu^{2+} luminescence.

2. EXPERIMENTAL SECTION

Eu-doped $\text{CsAlSi}_2\text{O}_6$ was prepared by the sol-gel method, which can give the highest possible homogeneity for the material. The doping level was 5.0 mol % according to the optimal doping value reported by Zhang et al.²⁸ The raw materials were a stoichiometric mixture of cesium nitrate (CsNO_3), $\text{Al}(\text{NO}_3)_3$, tetraethyl silicate ($\text{Si}(\text{OC}_2\text{H}_5)_4$, TEOS), Eu_2O_3 , and citric acid as the chelating agent. Briefly, the nitrate-europium solution was obtained by dissolving Eu_2O_3 in the diluted HNO_3 , which was mixed with CsNO_3 and $\text{Al}(\text{NO}_3)_3$ in an aqueous solution of citric acid (99.5%) under constant stirring at 60–80 °C until the clear solution “A” was obtained. Then TEOS was mixed with some diluted HNO_3 and ethanol. The mixtures were hydrolyzed for 30–60 min under stirring to form solution “B”. Then, A and B were mixed together and stirred for several hours at room temperature. Ethylene glycol (ethylene glycol and citric acid in a 4:1 molar ratio) can be added to promote the polymerization of the metal citrates by the polyesterification reaction. The solutions were slowly heated up to 100 °C and kept at this temperature for 2 h. The obtained gels were put into an oven to dry at 100–150 °C for 10–20 h to produce the porous solid resins; then solid resins were treated in air at 600 °C for 3–5 h. After that, the sample was thoroughly mixed and heated at 1300 °C for 5–10 h in air. This sample can be denoted as $\text{CsAlSi}_2\text{O}_6\text{-A}$, hereafter. In a comparison, the sample $\text{CsAlSi}_2\text{O}_6\text{:Eu}^{2+}$ prepared by heating it in a thermal ($\text{H}_2 + \text{N}_2$)-reducing atmosphere was denoted as $\text{CsAlSi}_2\text{O}_6\text{-C}$.

The phase purity was checked by powder X-ray diffraction (XRD) analysis collected on a Rigaku D/Max diffractometer operating at 40 kV, 30 mA with Bragg-Brentano geometry using $\text{Cu K}\alpha$ radiation ($\lambda = 1.5405 \text{ \AA}$). Scanning electron micrograph (SEM) images and electron-dispersive X-ray (EDX) were obtained using a JEOL JSM-6360 LA instrument. In this measurement, the powder samples were fixed on the conductive adhesive and coated with Au thin film. Electron spin resonance (ESR) measurement was made on a Bruker A-300 spectrometer working at the X-band frequency. The photoluminescence excitation and emission spectra were recorded on a PerkinElmer LS-50B luminescence spectrometer. The luminescence decay was measured using the fourth harmonic (266 nm) of a pulsed Nd:YAG laser.

3. RESULTS AND DISCUSSION

3.1. Crystal Phase Formation. Figure 1 shows the XRD profiles of the $\text{CsAlSi}_2\text{O}_6\text{-A}$ sample sintered in air and $\text{CsAlSi}_2\text{O}_6\text{-C}$ in a thermal ($\text{H}_2 + \text{N}_2$)-reducing atmosphere. The XRD diffraction peaks on the patterns can be well indexed according to the PDF2 standard card number No. 29-0407 ($\text{CsAlSi}_2\text{O}_6$) selected in the International Centre for Diffraction Data (ICDD) database. The two samples are all in the pure $\text{CsAlSi}_2\text{O}_6$ phase except for a few tiny extra diffraction peaks, which are in permitted limit.

Figure 2 shows the representative SEM micrograph of Eu-doped $\text{CsAlSi}_2\text{O}_6$ prepared in air (1300 °C for 7 h). The sample shows close packed and well-grown grains. The particles have very fine and irregular elliptical or ball shapes with an average size of 1–2 μm .

Figure 3a,b shows the SEM images of $\text{CsAlSi}_2\text{O}_6\text{-A}$ and $\text{CsAlSi}_2\text{O}_6\text{-C}$, respectively, in a low magnification. There is aggregation of the particles. Energy-dispersive X-ray (EDX) spectroscopy was used to examine the elemental compositions. The representative EDX spectra of the selected samples of $\text{CsAlSi}_2\text{O}_6\text{-A}$ and $\text{CsAlSi}_2\text{O}_6\text{-C}$ are shown in Figure 3c,d,

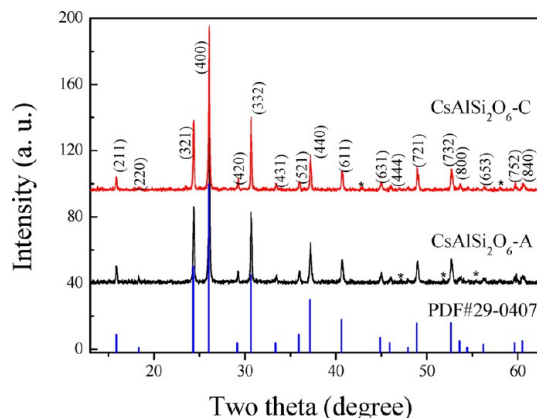


Figure 1. XRD patterns of Eu-doped $\text{CsAlSi}_2\text{O}_6$ prepared in air ($\text{CsAlSi}_2\text{O}_6\text{-A}$) and reducing atmosphere ($\text{CsAlSi}_2\text{O}_6\text{-C}$) in comparison with standard card PDF29-0407. The asterisk denotes some tiny extra diffraction peaks.

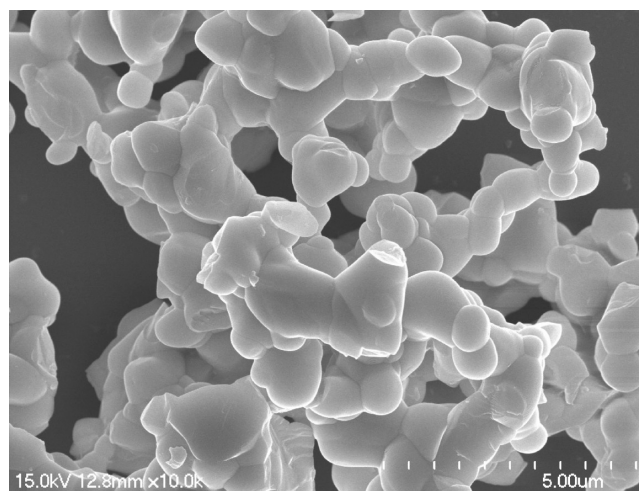


Figure 2. SEM micrograph of Eu-doped $\text{CsAlSi}_2\text{O}_6$ prepared in air (1300 °C for 7 h). The sample shows close packed and well-grown grains. The particles have very fine and irregular elliptical or ball shapes with an average size of 1–2 μm .

respectively. Several specific lines on the EDX spectra show the signals of Cs, Al, Si, O, and Eu, elements in the prepared samples. No other elements such as carbon can be detected, which could remain in the intermediate stages (referred to as solid resins) because the sol-gel synthetic route was used for the samples. The quantitative ratio for the different elements is listed in the insets in Figure 3. The EDX spectra confirm the presence of Cs, Al, Si, O, and Eu, and the approximate surface compositions of Cs, Al, and Si, extracted from the EDX analysis, are much closer to the theoretical value in $\text{CsAlSi}_2\text{O}_6$. The amount of Eu^{3+} obtained by EDX analysis in $\text{CsAlSi}_2\text{O}_6\text{-A}$ and $\text{CsAlSi}_2\text{O}_6\text{-C}$ was 1.48 and 1.65 atom %, respectively. The calculated values are lower than those in the precursors, but it can confirm Eu^{3+} doping in the lattices.

3.2. Photoluminescence Properties. It has been established that $4f^65d \rightarrow 4f^7$ emission transitions of Eu^{2+} in a compound are allowed, resulting in broad luminescence spectra and a very short lifetime in nanosecond to microsecond regions.^{29,30} Eu^{3+} ions show typical emission lines the spectral region of 570–725 nm corresponding $^5\text{D}_0 \rightarrow ^7\text{F}_j$ ($J = 0-4$) transitions with a lifetime longer than several milliseconds. So

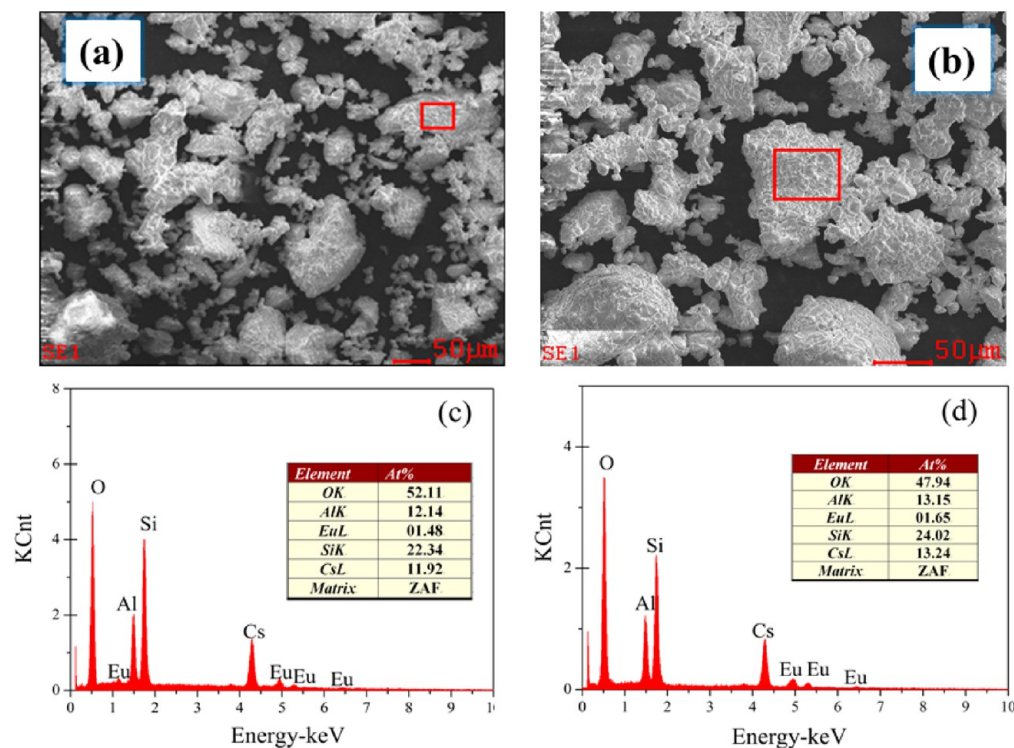


Figure 3. SEM images of CsAlSi₂O₆-A (a) and CsAlSi₂O₆-C (b) prepared at 1300 °C and (c, d) element EDX analysis of CsAlSi₂O₆-A and CsAlSi₂O₆-C, respectively. Insets show the quantitative ratio of the elements calculated from EDX data.

Eu²⁺ and Eu³⁺ can be well separated by very distinct spectra and luminescence decay curves (lifetimes).

The emission spectra of CsAlSi₂O₆:Eu prepared in air ($\lambda_{\text{ex}} = 300$ nm, $\lambda_{\text{ex}} = 395$ nm) are shown in Figure 4. The emission

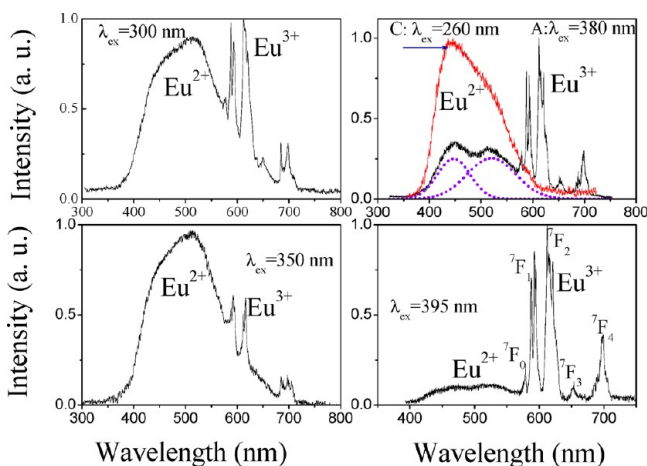


Figure 4. Emission spectra of CsAlSi₂O₆:Eu-A prepared in air ($\lambda_{\text{ex}} = 300, 350, 380,$ and 395 nm). Luminescence peaks from ⁵D₀ states of Eu³⁺ are labeled. The emission spectrum of CsAlSi₂O₆:Eu²⁺ prepared in reducing atmosphere (CsAlSi₂O₆-C) ($\lambda_{\text{ex}} = 260$ nm) was added for a comparison.

spectra present the broad band (350–600 nm) and sharp emission peaks. The emission peaks in the range from 570 to 650 nm clearly belong to the *f–f* transitions of ⁵D₀–⁷F_{*J*} (*J* = 0, 1, 2, 3, and 4) of Eu³⁺. Since the nondoped sample of CsAlSi₂O₆ does not show any light, the broad emission bands at 350 and 600 nm could be from the emissions of Eu²⁺ ions.

To identify the Eu²⁺ ions in CsAlSi₂O₆:Eu prepared in air, the emission spectrum of CsAlSi₂O₆:Eu²⁺ prepared in a thermal (H₂ + N₂)-reducing atmosphere (CsAlSi₂O₆-C) is shown in Figure 4 (C, $\lambda_{\text{ex}} = 260$ nm). By comparing the spectral characteristics of the emission bands in two samples, it is easily seen that the shapes and positions of the emission bands are almost the same. The same broad emission bands of Eu²⁺ ion in CsAlSi₂O₆ were situated from 350 to 600 nm, which were reported by Zhang et al.;²⁸ there are two emission bands at 440 and 530 nm with respective lifetimes of 1.18 and 2.76 μs. By the time-resolved spectra, the Eu³⁺ luminescence can be distinctly separated from Eu²⁺ as displayed in Figure 5. The emission spectra under short delay time show a dominate band from Eu²⁺. Under the time delay, 100 μs, the emission transitions ⁵D₀

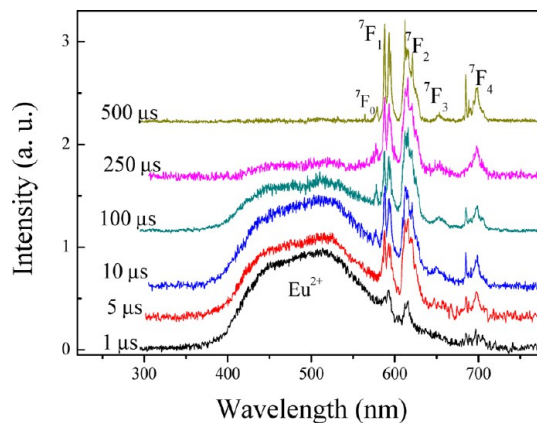


Figure 5. The time-resolved spectra of CsAlSi₂O₆:Eu prepared in air (CsAlSi₂O₆-A, $\lambda_{\text{ex}} = 266$ nm) measured at different delay times after the laser excitation as labeled on the figure.

→ ${}^7F_{0,1,2}$ from Eu^{3+} ions can be clearly observed. And the stronger Eu^{3+} emission can be observed with the decrease of Eu^{2+} emission by monitoring at a long delay time after laser excitation. This indicates that actually two valence states, +2, and +3, are available for Eu ions. Therefore, we can conclude that the reduction $\text{Eu}^{3+} \rightarrow \text{Eu}^{2+}$ took place in $\text{CsAlSi}_2\text{O}_6$ during the preparation in air at high temperature.

Figure 6 shows the excitation ($\lambda_{\text{em}} = 440, 530, \text{ or } 615 \text{ nm}$) spectra of Eu-doped $\text{CsAlSi}_2\text{O}_6$ prepared in air. Under

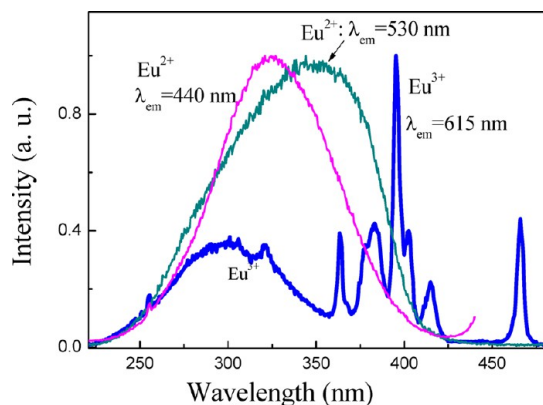


Figure 6. Excitation spectra of $\text{CsAlSi}_2\text{O}_6:\text{Eu}$ prepared in air ($\text{CsAlSi}_2\text{O}_6\text{-A}$, $\lambda_{\text{em}} = 440 \text{ nm}$, $\lambda_{\text{em}} = 530 \text{ nm}$, and $\lambda_{\text{em}} = 615 \text{ nm}$). Each spectrum was normalized to its maximum value.

monitoring at 440 and 530 nm, an intense and broad excitation band (250–400 nm) centered at 350 nm can be observed, which is ascribed to the $4f-5d$ transition of Eu^{2+} and overlaps the excitation band of the $\text{O}^{2+}-\text{Eu}^{3+}$ charge–transfer (CT) transition. The excitation spectrum monitored at 615 nm consists of some sharp lines belonging to transitions within the $4f^6$ configuration of Eu^{3+} and a broad band from 200 to 270 nm with a maximum at about 232 nm due to the $\text{O}^{2-} \rightarrow \text{Eu}^{3+}$ CT transition. Because the PL excitation spectra show strong absorption in the range of near-UV, $\text{CsAlSi}_2\text{O}_6:\text{Eu}$ could be a potential phosphor for white LEDs.²⁸

The ESR spectrum of Eu-doped $\text{CsAlSi}_2\text{O}_6$ prepared in air was measured to confirm the abnormal reduction process, as shown in Figure 7. It is well-known that Eu^{2+} (electronic configuration, $4f^7$; ground term, ${}^8S_{7/2}$) is ESR-active but Eu^{3+} ($4f^6$, 7F_0) is ESR-inert. The pronounced ESR signal from 250 to 400 mT at effective g -values of 2.0 can be found in Figure 7 for

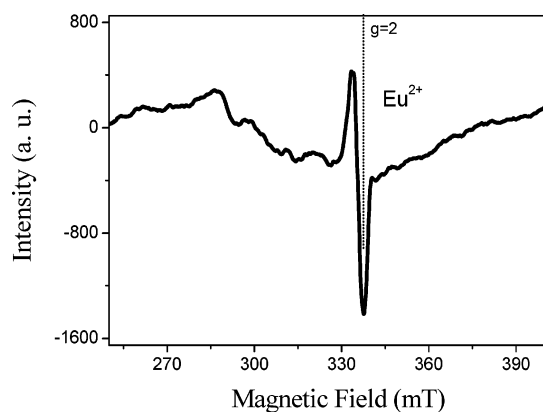


Figure 7. ESR signals at room temperature for Eu-doped $\text{CsAlSi}_2\text{O}_6$ prepared in air.

Eu-doped $\text{CsAlSi}_2\text{O}_6$ prepared in air. The result indicates the presence of Eu^{2+} ions in the sample. On the basis of the present data, it is difficult to give a quantitative ratio of $\text{Eu}^{2+}/\text{Eu}^{3+}$ from the emission intensities of the sample because the two luminescence centers have their own characteristic excitation wavelengths.

It is obvious that the samples present different colors under different excitation wavelength because of the mixed emission components from Eu^{2+} and Eu^{3+} . Figure 8 shows the CIE

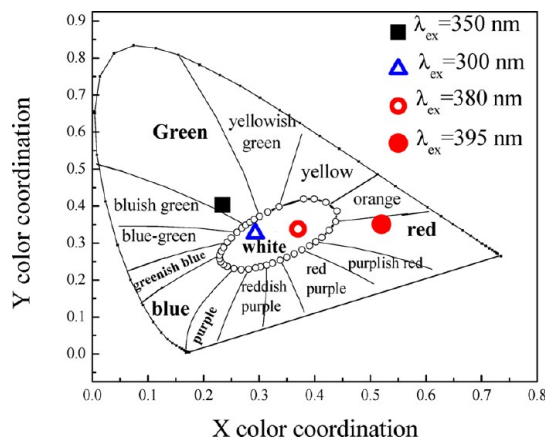


Figure 8. CIE chromaticity coordinates of $\text{CsAlSi}_2\text{O}_6:\text{Eu-A}$ prepared in air.

(Commission Internationale de l'Eclairage 1931) chromaticity diagram calculated from the emission spectra in Figure 4. This clearly displays rich luminescence colors under the different excitation wavelengths. The sample shows green color under 350 nm, while it displays red luminescence by the excitation of 395 nm ($f-f$ transition in Eu^{3+}). It is valuable that white color from a single phase in $\text{CsAlSi}_2\text{O}_6:\text{Eu}$ prepared in air can be realized under the excitation of 300 and 380 nm as shown in Figure 8.

3.3. Abnormal Reduction Mechanism of $\text{Eu}^{3+} \rightarrow \text{Eu}^{2+}$ in $\text{CsAlSi}_2\text{O}_6$. Abnormal reductions of $\text{RE}^{3+} \rightarrow \text{RE}^{2+}$ in a compound prepared in an oxidizing atmosphere have been reported in several kinds of compounds. Four conditions are necessary to realize the abnormal reduction,^{4,5,8,13,15} that is, (1) there is not oxidizing ions in the host, (2) RE^{3+} (or Eu^{3+}) substitutes a divalent cation, (3) the substituted cation and Eu^{2+} have similar radii, and (4) the host has a rigid structure, that is, having tetrahedral anion groups (BO_4 , SO_4 , PO_4 , SiO_4 , or AlO_4). Eu^{3+} -doped $\text{CsAlSi}_2\text{O}_6$ meets these conditions. And this is the first report of an abnormal reduction of Eu^{3+} substituted for an alkaline metal ion, not for an alkaline earth ion.

Of the four conditions, the last one is vital for an abnormal reduction. Pollucite, $\text{CsAlSi}_2\text{O}_6$, is a member of the analcime family crystallizing in the cubic system with space group $Ia\bar{3}d$. Figure 9 is the schematic view of the $\text{CsAlSi}_2\text{O}_6$ structure along c -direction. The framework is based on hexagonal and tetragonal rings of $(\text{Si,Al})\text{O}_4$ tetrahedra as shown in Figure 9a. Cs^+ ions in pollucite are coordinated with 12 oxygens and arranged in the channels along $[111]$ formed by hexagonal rings. Figure 9b displays CsO_{12} polyhedra forming chains along the $[111]$ direction. In this compound, all the O atoms are shared by the adjacent tetrahedra and all the bonds in the structure have the connection form of $(\text{Si, Al})-\text{O}-(\text{Si, Al})$,^{31,32} constructing a rigid aluminosilicate framework. The enclosed

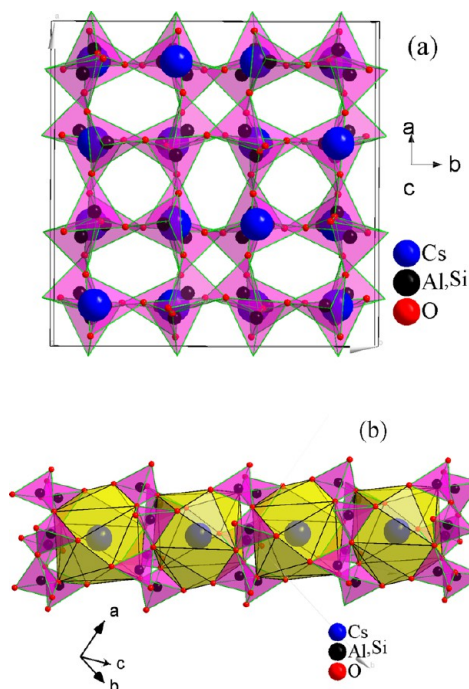
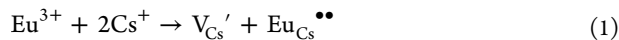


Figure 9. Schematic view of CsAlSi₂O₆ structure along *c*-direction (a) and CsO₁₂ chains along [111] direction (b).

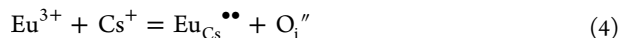
and stiff three-dimensional network structure matches condition 4.

The reduction of Eu³⁺ to Eu²⁺ when prepared in air at high temperature can be explained by a charge compensation mechanism. To keep the electroneutrality for the substitution of Eu³⁺ on Cs⁺, a cation vacancy defect, V_{Cs}['], with negative charge will compensate the induced positive defects of Eu_{Cs}^{••}, forming dipole complexes of [(Eu³⁺_{Cs})^{••}-2V_{Cs}[']]. The V_{Cs}['] would act as a donor of electrons, while Eu_{Cs}^{••} defects become acceptors of the electrons. Consequently, by thermal stimulation, the negative charges in the vacancy defects of V_{Cs}['] would be transferred to Eu³⁺ sites and reduce Eu³⁺ to Eu²⁺. The whole process can be expressed by the following equations:



According to the proposed reduction mechanism,^{4,5,8,13,15,33,34} the tetragonal AlO₄ and SiO₄ groups in the rigid three-dimensional framework can surround and isolate the produced divalent Eu²⁺ ions from reaction with oxygen.

Except for the charge compensation by cation vacancy, another mechanism related to the interstitial oxygen O_i^{''} is highly possible in CsAlSi₂O₆. The O_i^{''} with negative charge could be created because of the substitution of Eu³⁺ on Cs⁺, and dipole complexes of [(Eu³⁺_{Cs})^{••}-O_i^{''}] could be formed:



The framework of CsAlSi₂O₆ consists of corner-sharing (Si,Al)O₄ tetrahedra arranged in four-, six-, and eight-membered rings (Figure 9a). Cs⁺ ions occupy the cavity sites in 12-fold coordination, which are interconnected by channels through the six-member rings along [111] (Figure 9b). SiO₄

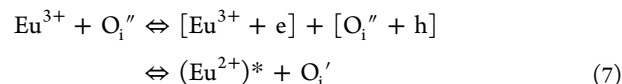
and AlO₄ tetrahedron construct a framework with enough cavities. There are ample spaces to arrange O_i^{''} to compensate the defects due to the substitution of Eu³⁺ on the Cs⁺ sites. It is not difficult to create O_i^{''} due to material preparation in air atmosphere.

Actually O_i^{''} was confirmed in Ti⁴⁺-doped CsAlSi₂O₆. In CsTi_xAl_{1-x}Si₂O_{6+0.5x} with Ti⁴⁺ substituting for Al³⁺ in pollucite, additional O²⁻ (O_i^{''}) is incorporated into the structure to maintain charge neutrality. The enthalpic variations were induced by the substitution Ti⁴⁺ + 1/2O²⁻ → Al³⁺ resulting in the corresponding changes in structure. As a result, the substituted Ti⁴⁺ becomes 5-fold coordinated by oxygen in comparison with 4-fold-coordination for Al³⁺. To achieve pentacoordinate geometry for every Ti⁴⁺, the oxygen was shared by two [TiO₅] pyramids via edge-sharing. The complete substitution of Ti⁴⁺ on Al³⁺ results in CsTiSi₂O_{6.5}.²⁵

The released electron from O_i^{''} could be captured at Eu³⁺ sites under a thermal stimulation resulting in the reduction of Eu³⁺ to Eu²⁺:



The total defect reaction is the following, which could be expressed by Eu²⁺ ions and a hole centers of O_i['].



In eq 7, the reduced Eu²⁺ is not the same as that in eq 3, where the electrons enter into the track of the Eu³⁺ ions. It could be suggested to be a kind of hydrogen-like atoms [Eu³⁺ + e]. However, the new measurements will be conducted in the next work to confirm the related O⁻ (O_i[']) hole centers.

Zhang et al.²⁸ suggested that Eu²⁺ ions could occupy more than one site in CsAlSi₂O₆Eu³⁺ lattices with luminescence centered at 440 nm (Eu_I) and 530 nm (Eu_{II}). As seen in Figure 4, the emission spectra in CsAlSi₂O₆-A prepared in air atmosphere have a broad band (300–600 nm) and sharp line peaks from the f–f transitions ⁵D₀ → ⁷F_J (J = 0–4) of Eu³⁺ ions. The broad spectra also have two obvious bands indicating two Eu²⁺ color centers in Eu-doped CsAlSi₂O₆-A. In this sample, it is reasonable that Eu³⁺ ions could have at least two kinds of crystallographic sites in the lattices. The multiple site structure for Eu³⁺ ions doping in CsAlSi₂O₆-A can be understood by the charge compensation model mentioned above.

3.4. Thermal Stability. The temperature dependent (20–300 K) emission spectra of CsAlSi₂O₆-C and CsAlSi₂O₆-A were measured, which are shown in Figures 10 and 11, respectively. The integrated intensities of Eu²⁺ emission on temperature are calculated and shown in the insets of the figures. It is observed that the emission intensity of Eu²⁺ in CsAlSi₂O₆-C is depressed with increasing temperature from 20 to 300 K. However, the reverse phenomena can be observed in CsAlSi₂O₆-A, that is, Eu²⁺ increases its intensity with increasing temperature from 20 to 300 K. The different stabilities on temperature for A and C should be closely related to the surrounding microstructures of Eu²⁺ ions in the lattices.

During this reduction process of Eu³⁺ to Eu²⁺ ions in CsAlSi₂O₆-C, the oxygen ions surrounding Eu³⁺ ions can be depleted by H₂ molecules when it is heated at high-temperature in (H₂ + N₂) gas.

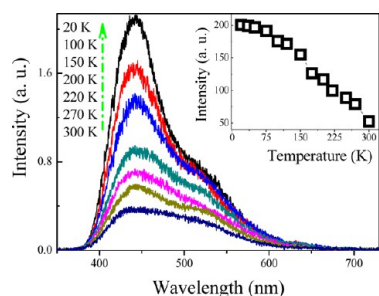


Figure 10. The dependence of the emission spectra of CsAlSi₂O₆:Eu prepared in reducing atmosphere (CsAlSi₂O₆-C) on the temperature 20–300 K. Inset is the total emission intensities (300–750 nm) integrated from the emission spectra.

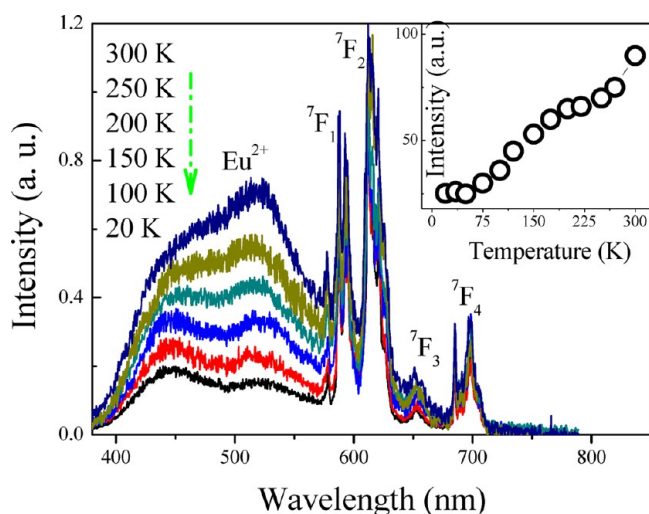
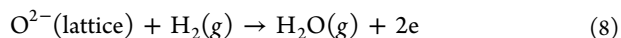
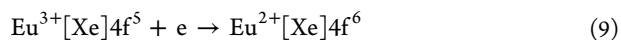


Figure 11. Temperature dependent emission spectra (20–300 K) of CsAlSi₂O₆:Eu prepared in air (CsAlSi₂O₆-A). Inset is the total emission intensities (300–750 nm) integrated from the emission spectra.



The released electrons diffuse into the crystal and complete the following reductive reaction of trivalent Eu³⁺.



The electron comes into the atom track of Eu²⁺. The enhancement of luminescence with decreasing temperature is due to weak electron–phonon interaction at low temperature.

However, the reduction of Eu³⁺ to Eu²⁺ in CsAlSi₂O₆-A is a different mechanism from that in CsAlSi₂O₆-C. There are two possible defect traps of [(Eu³⁺_{Cs})^{••}–O_i′] or [(Eu³⁺_{Cs})^{••}–2V_{Cs}′] in CsAlSi₂O₆-A. Eu²⁺ ions could be recombined with the electrons released from defects O_i′ or V_{Cs}′; however, the electrons do not enter the atom track of Eu²⁺ but loosely combine with Eu³⁺ in close vicinity (Eu³⁺ + e) presenting luminescence of Eu²⁺ under excitation. So the different defect traps in the matrix should be attributed to the mechanisms of Eu³⁺ to Eu²⁺ ions. With decreasing temperature, all the defects could be inert at low temperature and resulting in low luminescence of Eu²⁺ ion.

The decay curves of Eu²⁺ emission centers in CsAlSi₂O₆-C and CsAlSi₂O₆-A are displayed in Figures 12 and 13, respectively. The lifetime shows some quenching from 20 to 300 K. It can be found that the lifetimes of Eu²⁺ emission

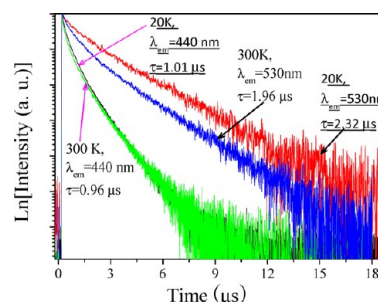


Figure 12. Decay curves of Eu²⁺ centers at 440 and 530 nm in CsAlSi₂O₆-C at 20 and 300 K.

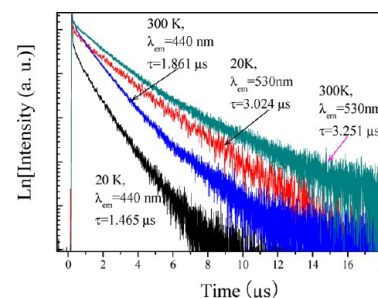


Figure 13. Decay curves of Eu²⁺ centers 440 and 530 nm in CsAlSi₂O₆-A at 20 and 300 K.

centers in CsAlSi₂O₆ show the unusual increase from 20 to 300 K; this deviates the well-known fact that the lifetimes of Eu²⁺ excited states usually decrease with temperature enhancement. Similar abnormal decrease of lifetime with increasing temperature has been reported in Eu²⁺-doped CaF₂,^{35,36} Ba₃SiO₄X₆ (X = Cl or Br),³⁷ and BaFBr³⁸ from 10 K to room temperature. This is a really complicated process, which was assigned to different mechanisms. In Eu²⁺-doped CaF₂ the increase of lifetime with increasing temperature was ascribed to the existence of states with lower oscillator strength lying above the lowest excited level.³⁵ The excited state ⁶P₁ produced by the f⁷ electron configuration of the Eu²⁺ ion is located above the lowest excited state produced by the f⁶d configuration. However, Tsuboi et al.³⁶ suggested that that two relaxed excited states (RESS) were responsible for the blue emission in CaF₂:Eu²⁺. The low-energy RES I is related to the lowest excited state of the f⁶d configuration, while the upper RES II is produced by the excited state of the f⁷ configuration. The transition from the RES II is forbidden. Consequentially, the transition was delayed at higher temperature. In Eu²⁺-Ba₃SiO₄X₆ (X = Cl or Br) Meijerink et al.³⁷ explained the unusual increase by the thermal population of higher energetic 4f⁶5d for which the transition probability to 4f⁷ (⁸S^{7/2}) ground states was smaller than for the lowest 4f⁶5d state. At present, it is still difficult to assign which is the real mechanism for Eu²⁺-doped CsAlSi₂O₆ because of the multiple site structure for Eu²⁺ ions in CsAlSi₂O₆.²⁸ The further work will be needed for the detailed crystallographic information.

It is well-known that in a system with two luminescence centers energy transfer could take place from the high-energy centers to another with a low energy level. For example, in the Ba₃LaNa(PO₄)₃F:Eu²⁺,Tb³⁺ phosphor, the blue emission (425–525 nm) of Eu²⁺ ions can be efficiently transferred to the low-energy-lying Tb³⁺ ions resulting in bright blue-green or pure green color.³⁹ In Eu²⁺ and Eu³⁺ codoped KCl, an

extraordinary emission feature can be produced via the process of energy reabsorption from Eu^{2+} to Eu^{3+} ions.⁴⁰ At all temperatures, the predominant emission is from the ${}^5\text{D}_0 \rightarrow {}^7\text{F}_2$ transitions of Eu^{3+} ions. In addition, the broad emission of Eu^{2+} overlaps the sharp excitation peaks originating from the f–f transition of Eu^{3+} . It is possible that energy transfer would occur from Eu^{2+} to Eu^{3+} . This kind of energy transfer could also take place in the sample with increasing or decreasing temperature; the detailed process is not clear. The main problem is that there are at least two kinds of luminescence for Eu^{2+} and Eu^{3+} in the sample lattices, and the detailed energy level diagram of the Eu^{2+} and Eu^{3+} ions in this crystal will be investigated in further work.

Figure 14 displays the decay curves of Eu^{3+} emission in the $\text{CsAlSi}_2\text{O}_6$ -A sample at several temperatures; the lifetimes of

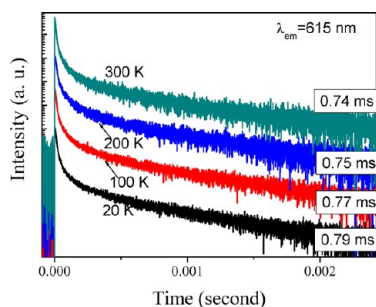


Figure 14. Decay curves of Eu^{3+} emission in $\text{CsAlSi}_2\text{O}_6$ -A sample at selected temperature from 20 to 300 K.

Eu^{3+} do not show obvious change at different temperatures (i.e., 20 and 300 K). This indicates that the luminescence of Eu^{3+} in the $\text{CsAlSi}_2\text{O}_6$ host has high thermal stability. This can benefit lighting and display applications.

4. CONCLUSIONS

Eu -doped $\text{CsAlSi}_2\text{O}_6$ was prepared by the sol–gel method and finally heated in air atmosphere at 1300 °C. The emission spectra of $\text{CsAlSi}_2\text{O}_6:\text{Eu}$ prepared in air present the broad band of Eu^{2+} and sharp emission lines corresponding to the ${}^5\text{D}_0\text{--}{}^7\text{F}_j$ ($J = 0, 1, 2, 3, \text{ and } 4$) transitions of Eu^{3+} . There are two valence states, +2 and +3, available for Eu ions. The time-resolved spectra can distinctly separate the Eu^{3+} luminescence from that of Eu^{2+} ions. This abnormal reduction $\text{Eu}^{3+} \rightarrow \text{Eu}^{2+}$ is closely related to the charge compensation mechanism and a rigid three-dimensional framework structure of $\text{CsAlSi}_2\text{O}_6$ containing tetrahedral anion groups, $(\text{Si,Al})\text{O}_4$. The substitution of Eu^{3+} on Cs^+ can induce possible defect complexes of $[(\text{Eu}^{3+}_{\text{Cs}})^{\bullet\bullet} - 2\text{V}_{\text{Cs}}']$ or $[(\text{Eu}^{3+}_{\text{Cs}})^{\bullet\bullet} - \text{O}_i'']$. In Eu^{2+} -doped $\text{CsAlSi}_2\text{O}_6$ prepared in reducing atmospheres, released electrons comes into the atom track of Eu^{2+} , resulting in complete reduction of Eu^{3+} to Eu^{2+} ions. This sample presents a luminescence enhancement with decreasing temperature due to weak electron–phonon interaction at low temperature. However, in Eu^{2+} -doped $\text{CsAlSi}_2\text{O}_6$ with an abnormal reduction, Eu^{2+} ions could be obtained by just loosely combining the released electrons from defects O_i'' or V_{Cs}' ; the electrons could be in close vicinity of Eu^{3+} ($\text{Eu}^{3+} + \text{e}$) and not enter the atom track of Eu^{2+} . This complex presents luminescence of Eu^{2+} ions. With decreasing temperature, all the defects could be inert at low temperature and resulting in decrease of luminescence of Eu^{2+} ion. So different defect traps are attributed to the abnormal reduction mechanism of Eu^{3+} to Eu^{2+} ions in a matrix.

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Notes

The authors declare no competing financial interest.

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